# mail

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

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Advance Technical Information

### High Current Power MOSFET

IXTH 88N15 IXTT 88N15

V <sub>DSS</sub>	=	150	V
I <sub>D25</sub>	=	88	Α
R <sub>DS(on)</sub>	=	22	mΩ

N-Channel Enhancement Mode

		•••			
Symbol	Test Conditions	Maximum Ratings			
V <sub>dss</sub> V <sub>dgr</sub>	$T_{J} = 25^{\circ}C$ to $150^{\circ}C$ $T_{J} = 25^{\circ}C$ to $150^{\circ}C$ ; $R_{GS} = 1 M\Omega$	150 150	V V		
V <sub>GS</sub> V <sub>GSM</sub>	Continuous Transient	±20 ±30	V V		
I <sub>D25</sub>	$T_c = 25^{\circ}C$	88	A		
I <sub>DM</sub>	$T_{c}$ = 25°C, pulse width limited by $T_{JM}$	352	А		
I <sub>AR</sub>	$T_{c} = 25^{\circ}C$	88	А		
E <sub>AR</sub>	$T_c = 25^{\circ}C$	50	mJ		
E <sub>AS</sub>	$T_c = 25^{\circ}C$	1.5	J		
dv/dt	$ \begin{split} I_{_{S}} &\leq I_{_{DM}},  di/dt \leq 100 \text{ A}/\mu \text{s},  V_{_{DD}} \leq V_{_{DSS}}, \\ T_{_{J}} &\leq 150^{\circ}\text{C},  \text{R}_{_{G}} = 2 \; \Omega \end{split} $	5	V/ns		
P <sub>D</sub>	$T_{c} = 25^{\circ}C$	400	W		
T		-55 +150	۵°		
Т <sub>јм</sub>		150	°C		
T <sub>stg</sub>		-55 +150	°C		
T	1.6 mm (0.062 in.) from case for 10 s	300			
M <sub>d</sub>	Mounting torque	1.13/10	Nm/lb.in.		
Weight	TO-247 AD TO-268	6 4	g g		



#### TO-268 (IXTT) Case Style



#### Features

- International standard packages
- Low R<sub>DS (on)</sub> HDMOS<sup>™</sup> process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- easy to drive and to protect

#### Advantages

- Easy to mount
- Space savings
- High power density

Symbol Test Conditions C			Ch	aracteristic Values			
$(T_{J} = 25^{\circ}C)$	C, unless otherwise specified)		Min.	Тур.	Max	.=	
V <sub>DSS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$		150			V	
V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0		4.0	V	
I <sub>GSS</sub>	$V_{GS} = \pm 20 V_{DC}, V_{DS} = 0$				±100	nA	
I <sub>DSS</sub>	$\begin{array}{l} V_{_{\mathrm{DS}}} = V_{_{\mathrm{DSS}}} \\ V_{_{\mathrm{GS}}} = 0 \ V \end{array}$	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			25 1	μA mA	
R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 0.5 \text{ I}_{D25}$ Pulse test, t < 300 µs, duty (	cvcle d ≤2%			22	mΩ	

## 

### IXTH 88N15 IXTT 88N15

Symbol	Test Conditions $(T_j = 25^{\circ}C, unless otherwise s$ $Min_j + Tyn_j + M$				ic Values specified)	
g <sub>fs</sub>	$V_{DS} = 10 \text{ V}; \text{ I}_{D} = 0.5 \text{ I}_{D25}, \text{ pulse test}$	35	48		S	
C <sub>iss</sub>	)		4000		pF	
C <sub>oss</sub>	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1 MHz$		1150		pF	
C <sub>rss</sub>	)		440		pF	
t <sub>d(on)</sub>	)		24		ns	
t,	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 0.5 \text{ V}_{DSS}, \text{ I}_{D} = 0.5 \text{ I}_{D25}$		33		ns	
t <sub>d(off)</sub>	$R_{g} = 2 \Omega $ (External)		80		ns	
t <sub>r</sub>	)		18		ns	
Q <sub>g(on)</sub>	)		170		nC	
$\mathbf{Q}_{gs}$	$V_{GS} = 10 \text{ V},  V_{DS} = 0.5  V_{DSS},        $		40		nC	
$\mathbf{Q}_{\mathrm{gd}}$	J		105		nC	
R <sub>thJC</sub>				0.31	K/W	
R <sub>thCK</sub>	(TO-247)		0.25		K/W	

Source-Drain Diode		n Diode	<b>Characteristic Val</b>			ues
Symbol		Test Conditions mir		typ.	max.	ieu)
I <sub>s</sub>		$V_{GS} = 0 V$			88	A
I <sub>sм</sub>		Repetitive			352	A
$V_{sd}$		$\begin{split} I_{_{F}} = I_{_{S}},  V_{_{GS}} = 0   V, \\ \text{Pulse test, } t \leq 300  \mu\text{s},  \text{duty cycle } d \in \mathcal{I} \end{split}$	≤2%		1.5	V
T <sub>rr</sub>	)	I <sub>F</sub> = 25A		150		ns
<b>Q</b> <sub>RM</sub>	}	-di/dt = 100 A/µs V <sub>R</sub> = 100V		2.5		μC

#### Min Recommended Footprint



IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

 4.835,592
 4.881,106
 5,017,508
 5,049,961
 5,187,117
 5,486,715
 6,306,728B1
 6,259,123B1
 6,306,728B1

 4.850,072
 4,931,844
 5,034,796
 5,063,307
 5,237,481
 5,381,025
 6,404,065B1
 6,162,665
 6,534,343

Terminals: 1 - Gate 2 - Drain 3 - Source Tab - Drain							
	Dim.	Milli Min.	meter Max.	Inc Min.	hes Max.		
	A	47	5.2	195	200		
		22	2 54	087	102		
	A	2.2	2.6	.059	.098		
	b	1.0	1.4	.040	.055		
	b,	1.65	2.13	.065	.084		
	b2	2.87	3.12	.113	.123		
	C	.4	.8	.016	.031		
	D	20.80	21.46	.819	.845		
	E	15.75	16.26	.610	.640		
	е	5.20	5.72	0.205	0.225		
	L	19.81	20.32	.780	.800		
	L1		4.50		.177		
	ØP	3.55	3.65	.140	.144		
	Q	5.89	6.40	0.232	0.252		
	R	4.32	5.49	.170	.216		
	S	6.15	BSC	242	BSC		

TO-247 AD Outline

#### TO-268 Outline

